



**INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATION**

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APPLICANT  
**Shigeya NARITSUKA, et al.**

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**U.S. PATENT DOCUMENTS**

CITE NO.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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						Yes	No
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**OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		Zhang, S., et al. "LPE Lateral Overgrowth of GaP" Japanese Journal of Applied Physics, March 1990, Vol. 29, No. 3, pp. 545-550.

EXAMINER  
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03/27/2010

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